Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/505,318	HASHIMOTO ET AL.		
Examiner	Art Unit		
Diem Tran	3748		

SEARCHED					
Class	Subclass	Date	Examiner		
60	274 286	9/8/05	DT		
	295				
	297				
	303				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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consulted w/ C. Pham	9/05	DT		